Author's Accepted Manuscript

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PII: S0022-4596(17)30275-X

DOI: http://dx.doi.org/10.1016/j.jssc.2017.07.014

Reference: **YJSSC19864**

To appear in: Journal of Solid State Chemistry

Received date: 7 April 2017 Revised date: 4 June 2017 Accepted date: 8 July 2017

Cite this article as: O.Y. Khyzhun, O.V. Parasyuk, O.V. Tsisar, L.V. Piskach, G.L. Myronchuk, V.O. Levytskyy and V.S. Babizhetskyy, New quaternary thallium indium germanium selenide TlInGe₂Se₆: Crystal and electroni structure. Journal Solid State Chemistry http://dx.doi.org/10.1016/j.jssc.2017.07.014

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New quaternary thallium indium germanium selenide TlInGe₂Se₆: Crystal and electronic structure

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Abstract

Crystal structure of a novel quaternary thallium indium germanium selenide TIInGe₂Se₆ was investigated by means of powder X-ray diffraction method. It was determined that the compound crystallizes in the trigonal space group R3 with the unit cell parameters a=10.1798(2) Å, c=9.2872(3) Å. The relationship with similar structures was discussed. The as-synthesized TIInGe₂Se₆ ingot was tested with X-ray photoelectron spectroscopy (XPS) and X-ray emission spectroscopy (XES). In particular, the XPS valence-band and core-level spectra were recorded for initial and Ar⁺ ion-bombarded surfaces of the sample under consideration. The XPS data allow for statement that the TIInGe₂Se₆ surface is rigid with respect to Ar⁺ ion-bombardment. Particularly, Ar⁺ ion-bombardment (3.0 keV, 5 min duration, ion current density fixed at 14 μ A/cm²) did not cause substantial modifications of stoichiometry in topmost surface layers. Furthermore, comparison on a common energy scale of the XES Se K β_2 and Ge K β_2 bands and the XPS valence-band spectrum reveals that the principal contributions of the Se 4p and Ge 4p states occur in the upper and central portions of the valence band of TIInGe₂Se₆, respectively, with also their substantial contributions in

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